

# SIGC18T60UN

# High Speed IGBT Chip in NPT-technology

# FEATURES:

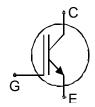
- low Eoff
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

## This chip is used for:

• SGP20N60HS

# **Applications:**

- Welding
- PFC
- UPS



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC18T60UN	600V	20A	4.3 x 4.3 mm <sup>2</sup>	sawn on foil	Q67050-A4222- A101

## **MECHANICAL PARAMETER:**

Raster size	4.3 x 4.3					
Area total / active	18.5 / 14.2					
Emitter pad size	2.986 x 2.486					
Gate pad size	1.078 x 0.696					
Thickness	100	μm				
Wafer size	150	mm				
Flat position	270	deg				
Max.possible chips per wafer	796					
Passivation frontside	Photoimide	Photoimide				
Emitter metallization	3200 nm Al Si 1%					
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding					
Die bond	electrically conductive glue or solder					
Wire bond	AI, ≤500µm					
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm					
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C					



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	60	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 +150	°C

<sup>1)</sup> depending on thermal properties of assembly

**STATIC CHARACTERISTICS** (tested on chip),  $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	•
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V, I <sub>C</sub> =500µA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =20A		2.8	3.15	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C$ =500µA, $V_{GE}$ = $V_{CE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			1.5	μA
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}$ =0V, $V_{GE}$ =20V			100	nA

#### DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
i arameter	Symbol	Conditions	min.	typ.	max.	
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	1100		pF
Output capacitance	Coss	V <sub>GE</sub> =0V f=1MHz	-	105		]
Reverse transfer capacitance	Crss		-	64		

#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

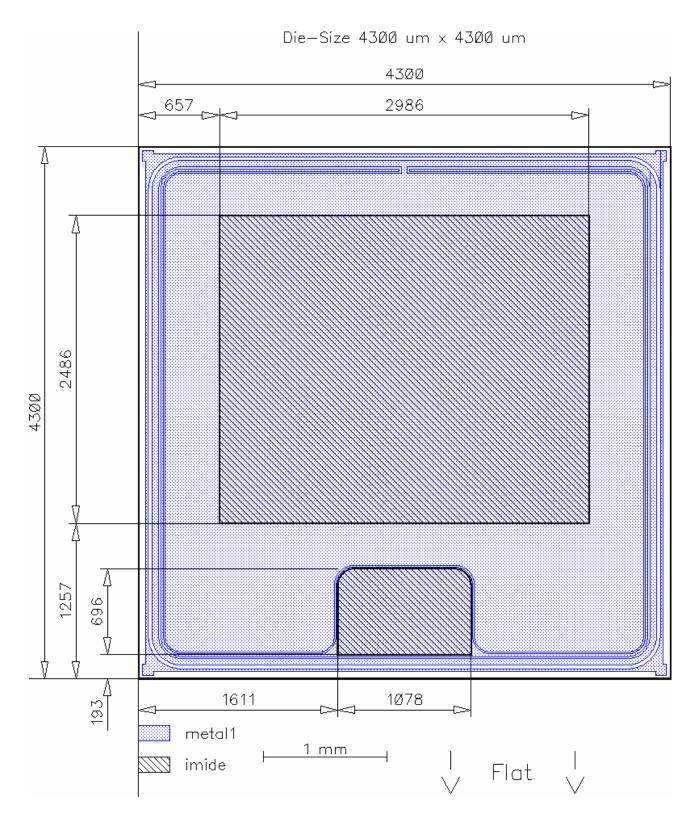
Parameter	Symbol	Conditions <sup>1)</sup>	Value			Unit
			min.	typ.	max.	
Turn-on delay time	t <sub>d(on)</sub>	$T_j = 150 \circ C$	-	15		ns
Rise time	t <sub>r</sub>	V <sub>CC</sub> =400V I <sub>C</sub> =20A	-	8.5		
Turn-off delay time	$t_{d(off)}$	V <sub>GE</sub> =+15/0V	-	65		
Fall time	t <sub>f</sub>	$R_{\rm G}=2.2\Omega$	-	35		

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



SIGC18T60UN

# CHIP DRAWING:





#### FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGP20N60HS

Package :TO220

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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